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**Examiner**

Art Unit

2122

[illegible]

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
717	151 + text	2.2.06	ms
712	210 + text	2.2.06	ms

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Fast V 2.0.1.4 US Pat US PG Pubs EPO JPO Derwent IBM Tech Bul	12-2-2004	MS
Fast V 2.0.1.4 US Pat US PG Pub EPO SPO Derwent IBM Tech Bul	2-2-06	MS
Palm Invention Names Search	2-2-06	MS
Daniel Pan (XP2183)	1-24-06	MS
Richard Ellis (XP2183)	1-26-06	MS
Marc Bookbinder TQAS 101 Panel	2-2-06	MS
New Patent List IEEE ACM	1-26-06 + 2-2-06	MS
Wei Zhou (SPE2191)	1-24-06	MS